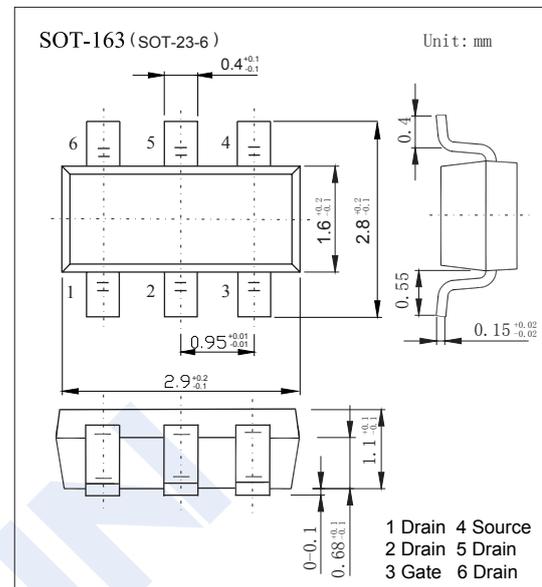
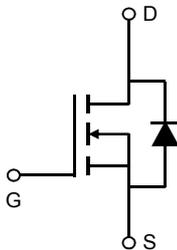


## N-Channel MOSFET

### AO6422 (KO6422)

#### ■ Features

- $V_{DS} (V) = 20V$
- $I_D = 5 A (V_{GS} = 4.5V)$
- $R_{DS(ON)} < 44m\Omega (V_{GS} = 4.5V)$
- $R_{DS(ON)} < 55m\Omega (V_{GS} = 2.5V)$
- $R_{DS(ON)} < 72m\Omega (V_{GS} = 1.8V)$



#### ■ Absolute Maximum Ratings $T_a = 25^\circ C$

Parameter	Symbol	10 Sec	Steady State	Unit
Drain-Source Voltage	$V_{DS}$	20		V
Gate-Source Voltage	$V_{GS}$	$\pm 8$		
Continuous Drain Current	$I_D$	5	3.9	A
		4.2	3	
Pulsed Drain Current	$I_{DM}$	30		
Power Dissipation	$P_D$	2	1.1	W
		1.3	0.7	
Thermal Resistance.Junction- to-Ambient	$R_{thJA}$	62.5	110	$^\circ C/W$
Thermal Resistance.Junction- to-Lead	$R_{thJL}$	-	68	
Junction Temperature	$T_J$	150		$^\circ C$
Storage Temperature Range	$T_{stg}$	-55 to 150		

## N-Channel MOSFET

## AO6422 (K06422)

## ■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V <sub>DSS</sub>	I <sub>D</sub> =250 μA, V <sub>GS</sub> =0V	20			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>Ds</sub> =20V, V <sub>GS</sub> =0V			1	μA
		V <sub>Ds</sub> =20V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C			5	
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>Ds</sub> =0V, V <sub>GS</sub> =±8V			±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>Ds</sub> =V <sub>GS</sub> , I <sub>D</sub> =250 μA	0.4		1	V
Static Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =4.5V, I <sub>D</sub> =5A			44	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =5A, T <sub>J</sub> =125°C			60	
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =4.5A			55	
		V <sub>GS</sub> =1.8V, I <sub>D</sub> =3.5A			72	
On State Drain Current	I <sub>D(on)</sub>	V <sub>GS</sub> =4.5V, V <sub>Ds</sub> =5V	30			A
Forward Transconductance	g <sub>FS</sub>	V <sub>Ds</sub> =5V, I <sub>D</sub> =5A		14		S
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>Ds</sub> =10V, f=1MHz		450	560	pF
Output Capacitance	C <sub>oss</sub>			74		
Reverse Transfer Capacitance	C <sub>rss</sub>			52		
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> =0V, V <sub>Ds</sub> =0V, f=1MHz		4.9	7.5	Ω
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> =4.5V, V <sub>Ds</sub> =10V, I <sub>D</sub> =5A		6.2	8.2	nC
Gate Source Charge	Q <sub>gs</sub>			0.4		
Gate Drain Charge	Q <sub>gd</sub>			1.3		
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>GS</sub> =4.5V, V <sub>Ds</sub> =10V, R <sub>L</sub> =2Ω, R <sub>G</sub> =3Ω		4.5		ns
Turn-On Rise Time	t <sub>r</sub>			6		
Turn-Off Delay Time	t <sub>d(off)</sub>			33		
Turn-Off Fall Time	t <sub>f</sub>			7.1		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =5A, dI/dt=100A/μs		13	17	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			3.3		
Maximum Body-Diode Continuous Current	I <sub>S</sub>				2	A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			1	V

\* The static characteristics in Figures 1 to 6 are obtained using <300us pulses, duty cycle 0.5% max.

## ■ Marking

Marking	DR**
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## N-Channel MOSFET AO6422 (KO6422)

■ Typical Characteristics

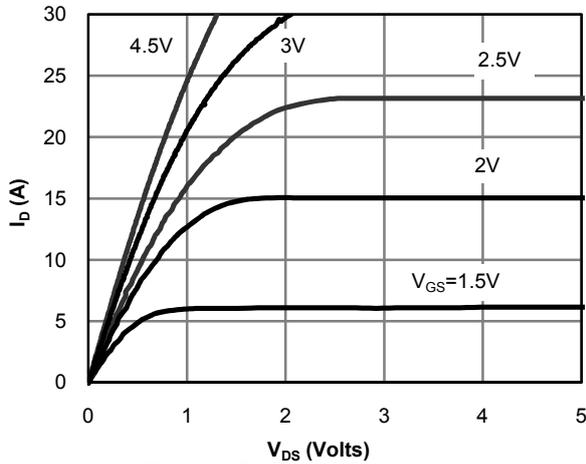


Figure 1: On-Region Characteristics

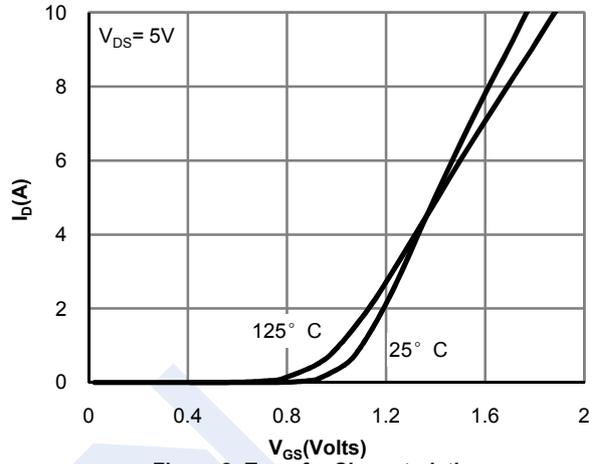


Figure 2: Transfer Characteristics

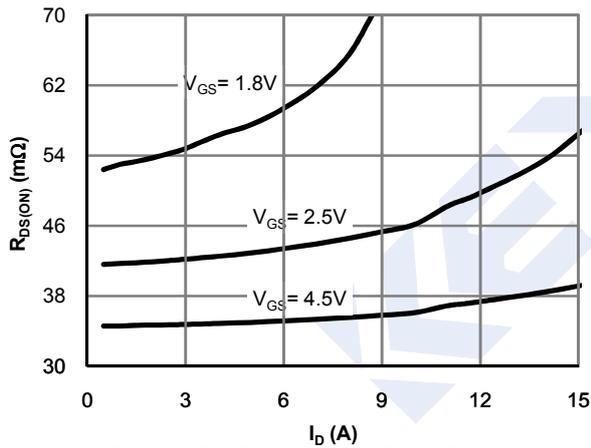


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

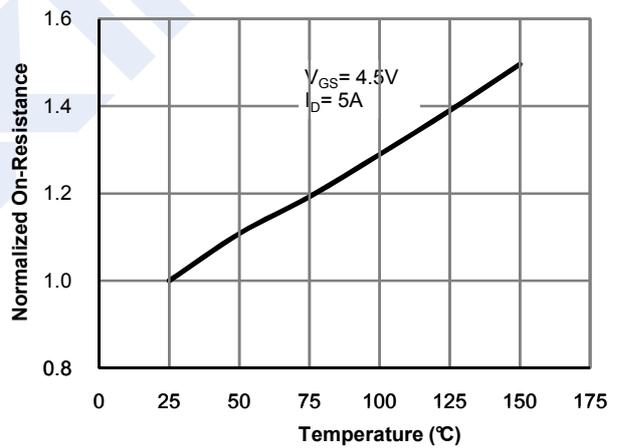


Figure 4: On-Resistance vs. Junction Temperature

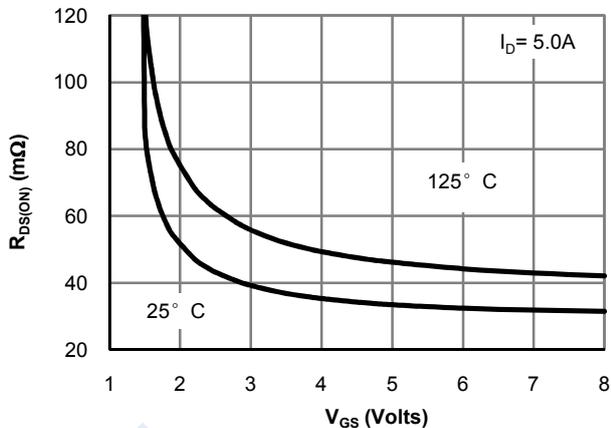


Figure 5: On-Resistance vs. Gate-Source Voltage

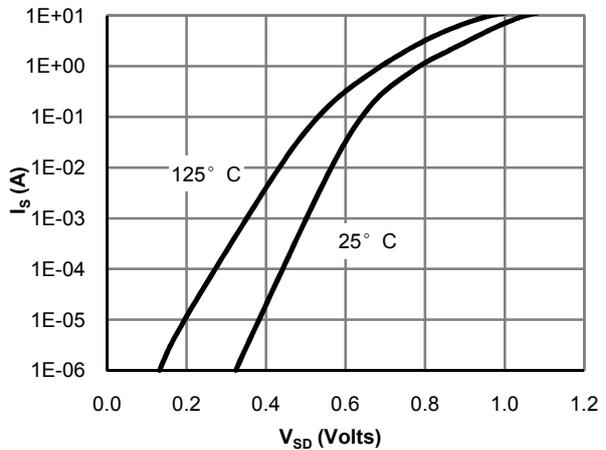


Figure 6: Body-Diode Characteristics

## N-Channel MOSFET AO6422 (KO6422)

■ Typical Characteristics

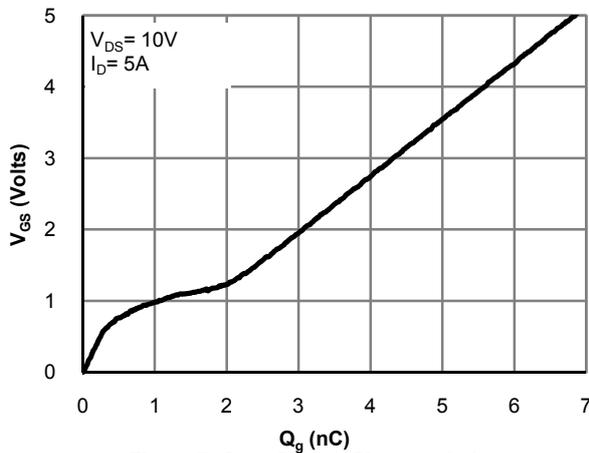


Figure 7: Gate-Charge Characteristics

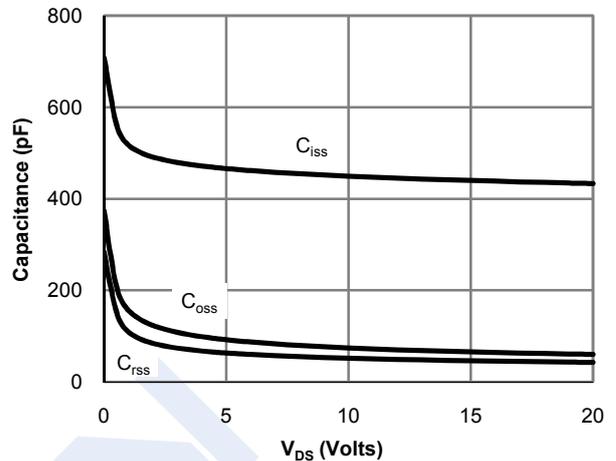


Figure 8: Capacitance Characteristics

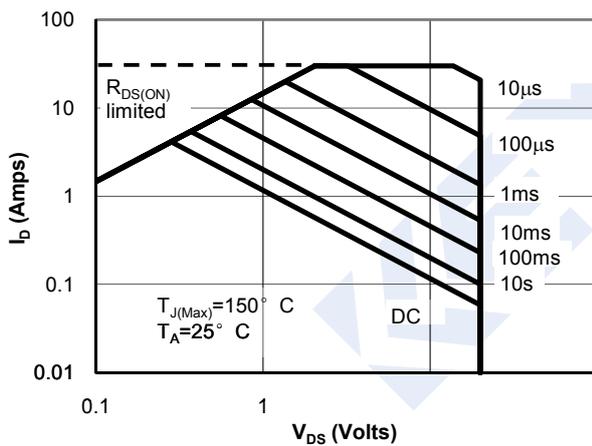


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

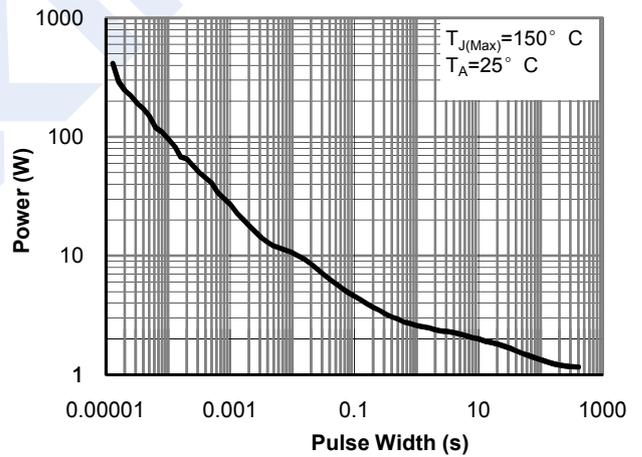


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

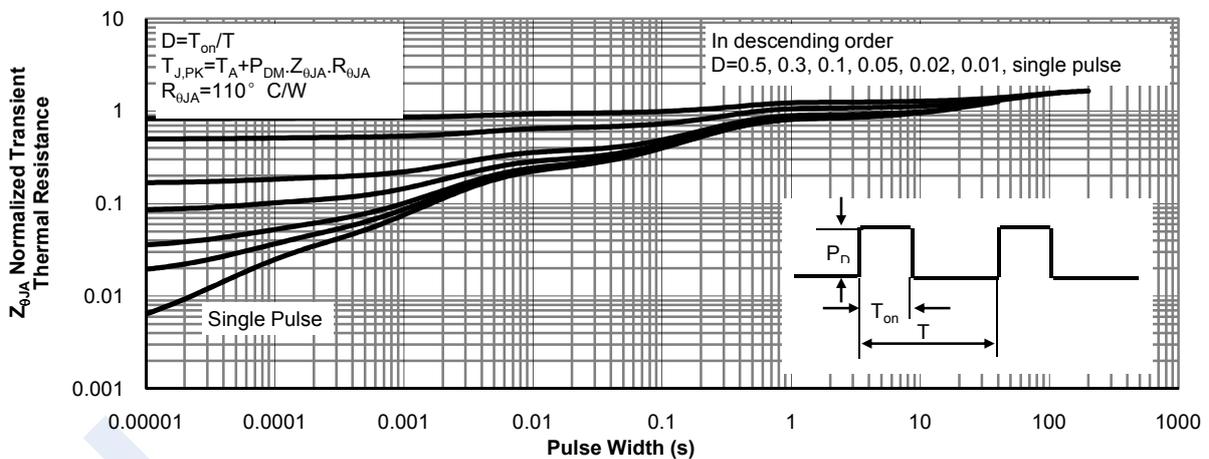


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)